Power MOSFET 30 V, 3.6 m Ω , 102 A, Single N–Channel, μ8FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVTFS4C05NWF Wettable Flanks Product
- NVT Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Parameter			Symbol	Value	Unit
Drain-to-Source Voltage			V _{DSS}	30	V
Gate-to-Source Voltage			V _{GS}	±20	V
Continuous Drain Current R _{θJA}		$T_A = 25^{\circ}C$	Ι _D	22	A
(Notes 1, 2, 4)		$T_A = 100^{\circ}C$		15.7	
Power Dissipation $R_{\theta JA}$		T _A = 25°C	PD	3.2	W
(Notes 1, 2, 4)	Steady	$T_A = 100^{\circ}C$		1.6	
Continuous Drain Current $R_{\psi JC}$	State	$T_C = 25^{\circ}C$	Ι _D	102	A
(Notes 1, 3, 4)		$T_C = 100^{\circ}C$		72	
Power Dissipation		T _C = 25°C	PD	68	W
$R_{\psi JC}$ (Notes 1, 3, 4)		$T_C = 100^{\circ}C$		34	
Pulsed Drain Current	$T_A = 25^{\circ}C, t_p = 10 \ \mu s$		I _{DM}	433	А
Operating Junction and Storage Temperature			T _J , T _{stg}	–55 to +175	°C
Source Current (Body Diode)			I _S	65	А
Single Pulse Drain–to–Source Avalanche Energy (T_J = 25°C, V_{GS} = 10 V, I_L = 18.8 A, L = 0.5 mH)			E _{AS}	88	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Notes 1, 3)	R_{\psiJC}	2.2	°C/W
Junction-to-Ambient - Steady State (Notes 1, 2)	R_{\thetaJA}	47	

1. The entire application environment impacts the thermal resistance values shown; they are not constants and are valid for the specific conditions noted.

2. Surface-mounted on FR4 board using 650 mm², 2 oz. Cu Pad.

3. Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.

4. Continuous DC current rating. Maximum current for pulses as long as one second is higher but dependent on pulse duration and duty cycle.

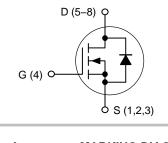


ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	3.6 mΩ @ 10 V	102 A
30 V	5.1 mΩ @ 4.5 V	102 A





MARKING DIAGRAM 1 sd WDFN8 XXXX S Γ AYWW-(µ8FL) sd CASE 511AB GΓ

b D

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4C05	= Specific Device Code for
	NVMTS4C05N
05WF	= Specific Device Code of
	NVTFS4C05NWF
А	= Assembly Location
Y	= Year
WW	= Work Week
	= Pb-Free Package
	-

(Note: Microdot may be in either location)

ORDERING INFORMATION

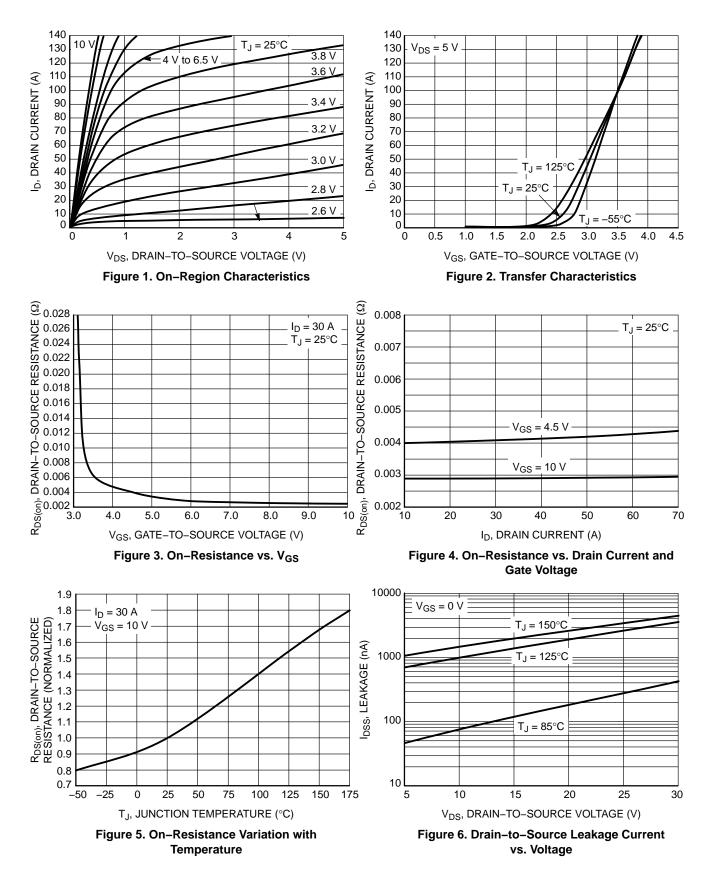
See detailed ordering, marking and shipping information on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

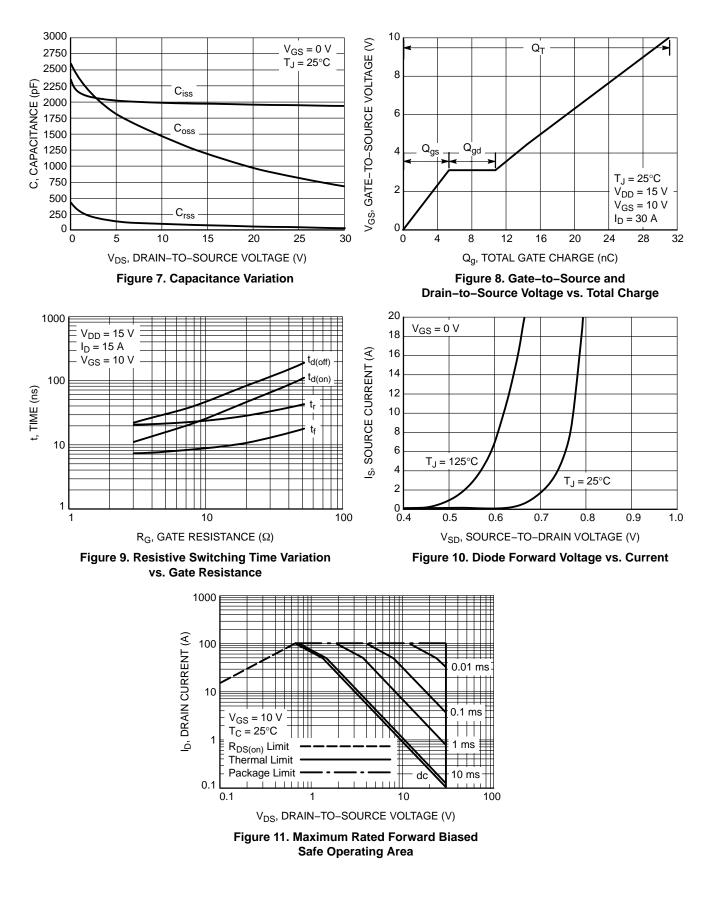
Parameter	Symbol	Test Cone	dition	Min	Тур	Max	Unit
OFF CHARACTERISTICS							
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 V, I_D$	= 250 μA	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				11.7		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$	$T_J = 25^{\circ}C$			1.0	
		$V_{DS} = 24 V$	$T_J = 125^{\circ}C$			10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$				±100	nA
ON CHARACTERISTICS (Note 5)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D = 250 \ \mu A$		1.3		2.2	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-5.0		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		2.9	3.6	
		V _{GS} = 4.5 V	I _D = 30 A		4.1	5.1	mΩ
Forward Transconductance	9 _{FS}	V _{DS} = 1.5 V,	I _D = 15 A		68		S
Gate Resistance	R _G	T _A = 25	5°C		1.0		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}				1988		Τ
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 M	Hz, V _{DS} = 15 V		1224		pF
Reverse Transfer Capacitance	C _{RSS}				71		
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz			0.036		
Total Gate Charge	Q _{G(TOT)}				14.5		1
Threshold Gate Charge	Q _{G(TH)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$ $V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V}; I_D = 30 \text{ A}$			2.9		nC
Gate-to-Source Charge	Q _{GS}				5.2		
Gate-to-Drain Charge	Q _{GD}				5.5		
Gate Plateau Voltage	V _{GP}				3.1		V
Total Gate Charge	Q _{G(TOT)}				31		nC
SWITCHING CHARACTERISTICS (Note	96)						
Turn–On Delay Time	t _{d(ON)}				11		
Rise Time	t _r	V _{GS} = 4.5 V, V	e = 15 V,		30		- ns
Turn–Off Delay Time	t _{d(OFF)}	V _{GS} = 4.5 V, V I _D = 15 A, R _C	$S = 3.0 \Omega$		20		
Fall Time	t _f				8.0		1
Turn–On Delay Time	t _{d(ON)}	V_{GS} = 10 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω			8.0		
Rise Time	t _r				25		ns
Turn–Off Delay Time	t _{d(OFF)}				26		
Fall Time	t _f				5.0		
DRAIN-SOURCE DIODE CHARACTER	ISTICS						
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.77	1.1	
		$I_{\rm S} = 10 \rm{A}$	T _J = 125°C		0.62		V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dIS/dt = 100 A/µs, I _S = 30 A			42.4		ns
Charge Time	ta				21.1		
Discharge Time	t _b				21.3		
Reverse Recovery Charge	Q _{RR}				34.4		nC

 $\begin{array}{ll} \text{5. Pulse Test: pulse width} \leq 300 \ \mu\text{s}, \ \text{duty cycle} \leq 2\%. \\ \text{6. Switching characteristics are independent of operating junction temperatures.} \end{array}$

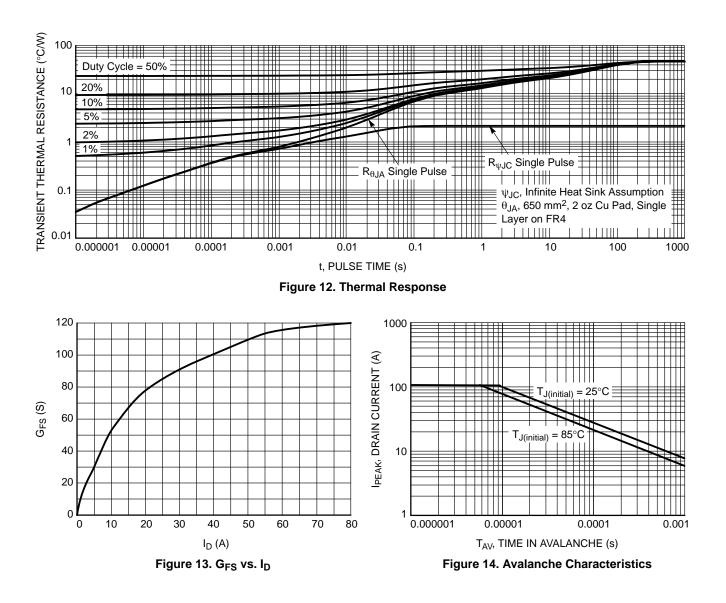
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



ORDERING INFORMATION

Device	Package	Shipping [†]
NVTFS4C05NTAG	WDFN8 (Pb–Free)	1500 / Tape & Reel
NVTFS4C05NWFTAG	WDFN8 (Pb–Free)	1500 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

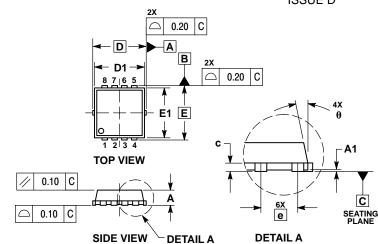
WDFN8 3.3x3.3, 0.65P CASE 511AB

ISSUE D

NOTES

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D2

BOTTOM VIEW

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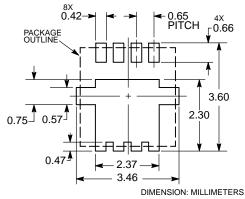
MILLIMETERS INCHES DIM MIN NOM MAX MIN NOM MAX 0.70 0.75 0.80 0.028 0.030 0.031 А A1 0.00 0.000 0.002 0.05 0.23 0.30 0.009 0.012 0.016 b 0.40 0.20 0.008 0.010 0.15 0.25 0.006 С D 3.30 BS0 0.130 BS0 D1 2.95 3.05 2.11 3.15 0.116 0.120 0.124 D2 2.24 0.083 0.088 1.98 0.078 Е 3.30 BSC 0.130 BS 0.116 0.124 E1 2.95 3.05 3.15 0.120 E2 1.73 0.068 1.47 0.058 0.063 1.60 0.30 0.40 0.012 E3 0.23 0.009 0.016 0.026 BS(е 0.65 BS0 0.51 0.012 0.016 0.020 G 0.30 0.41 κ 0.95 0.65 0.80 0.026 0.032 0.037 0.012 0.017 0.022 L 0.30 0.43 0.56 L1 0.06 0.13 0.20 0.002 0.005 0.008 Μ 1.40 1.50 1.60 12 ° 0.055 0.059 0.063

DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS.

DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH

PROTRUSIONS OR GATE BURRS.

SOLDERING FOOTPRINT*



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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